

### Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	$I_D@25^{\circ}C$
1200V	16m $\Omega$ @15V	140A
	14m $\Omega$ @18V	

### Feature

- Wide bandgap SiC MOSFET technology
- Low On-Resistance with High Blocking Voltage
- Low Capacitances with High-Speed switching
- Low reverse recovery(Qrr)

### Application

- Switch Mode Power Supplies
- Renewable Energy
- Motor Drives
- High Voltage DC/DC Converters

### Package

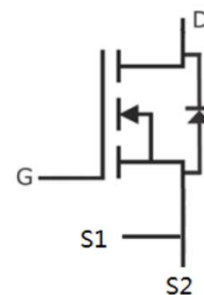


TO-247-4

### Marking



### Circuit diagram



### Absolute maximum ratings ( $T_C=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition	Value	Unit
Drain-Source Voltage	$V_{DS}$	$V_{GS} = 0V, I_D = 100\mu A$	1200	V
Gate-Source Voltage	$V_{GSmax}$	AC ( $f > 1$ Hz)	-10/+25	V
Gate-Source Voltage	$V_{GSOP}$	Static	-4/+15 -4/+18	V
Continuous Drain Current	$I_D$	$V_{GS} = 15V, T_C=25^{\circ}C$ $V_{GS} = 18V, T_C=25^{\circ}C$	140	A
		$V_{GS} = 15V, T_C=100^{\circ}C$ $V_{GS} = 18V, T_C=100^{\circ}C$	99	A
Pulsed Drain Current	$I_{D,pulse}$	Pulse with $t_p$ limited by $T_{jmax}$ at 1 ms Pulse with $t_p$ limited by $T_{jmax}$ at 100 $\mu s$	243 477	A
Power Dissipation	$P_D$	$T_C=25^{\circ}C$	577	W
Thermal Resistance (Typ)	$R_{\theta JC}$	Junction-to-Case	0.26	K/W
Junction Temperature	$T_J$		-55~ +175	$^{\circ}C$
Storage Temperature	$T_{STG}$		-55~ +175	$^{\circ}C$

### Electrical characteristics (T<sub>j</sub>=25°C, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 100μA	1200			V
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 1200V, V <sub>GS</sub> = 0V, T <sub>j</sub> = 25°C		1	50	μA
Gate-Source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> = 15V, V <sub>DS</sub> = 0V			250	nA
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 25mA		2.9		V
		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 25mA, T <sub>j</sub> = 175°C		2.0		
Drain-source on-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 15V, I <sub>D</sub> = 75A		16	24	mΩ
		V <sub>GS</sub> = 18V, I <sub>D</sub> = 75A		14		
		V <sub>GS</sub> = 15V, I <sub>D</sub> = 75A, T <sub>j</sub> = 175°C		30		
		V <sub>GS</sub> = 18V, I <sub>D</sub> = 75A, T <sub>j</sub> = 175°C		28		
Transconductance	g <sub>fs</sub>	V <sub>GS</sub> = 15V, I <sub>D</sub> = 75A		63		S
		V <sub>GS</sub> = 15V, I <sub>D</sub> = 75A, T <sub>j</sub> = 175°C		58		
<b>Dynamic characteristics</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 1000V, V <sub>GS</sub> = 0V, f = 100KHz V <sub>AC</sub> = 25mV		6534		pF
Output Capacitance	C <sub>oss</sub>			212		
Reverse Transfer Capacitance	C <sub>rss</sub>			21		
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = 800V, I <sub>D</sub> = 75A V <sub>GS</sub> = -4V/15V		221		nC
Gate-Source Charge	Q <sub>gs</sub>			113		
Gate-Drain Charge	Q <sub>gd</sub>			49		
Internal Gate Resistance	R <sub>G(int)</sub>	f = 1 MHz, V <sub>AC</sub> = 25mV		1.3		Ω
<b>Source-Drain Diode characteristics</b>						
Diode Forward Current	I <sub>S</sub>	V <sub>GS</sub> = -4V, T <sub>C</sub> = 25°C		129		A
Diode Forward voltage	V <sub>SD</sub>	V <sub>GS</sub> = -4V, I <sub>SD</sub> = 37.5A		4.0		V
		V <sub>GS</sub> = -4V, I <sub>SD</sub> = 37.5A, T <sub>J</sub> = 175°C		3.5		V
Diode pulse Current	I <sub>S, pulse</sub>	V <sub>GS</sub> = -4V, pulse width t <sub>p</sub> limited by T <sub>jmax</sub>		243		A

## Typical Characteristics

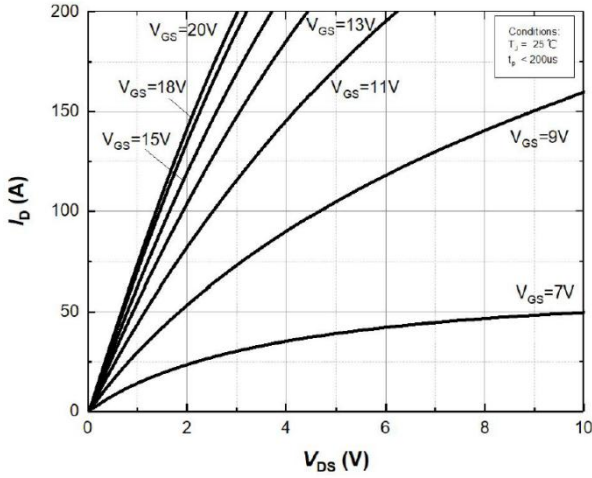


Figure 1. Output characteristics at  $T_j=25^\circ\text{C}$

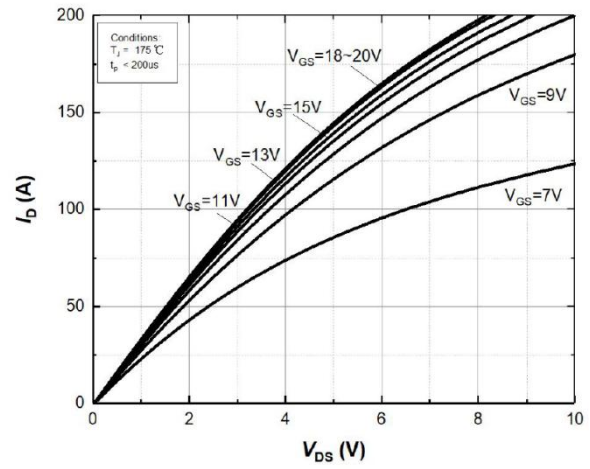


Figure 2. Output characteristics at  $T_j=175^\circ\text{C}$

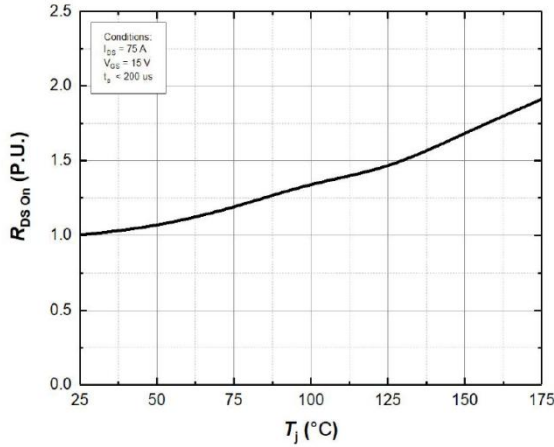


Figure 3. Normalized On-Resistance vs. Temperature

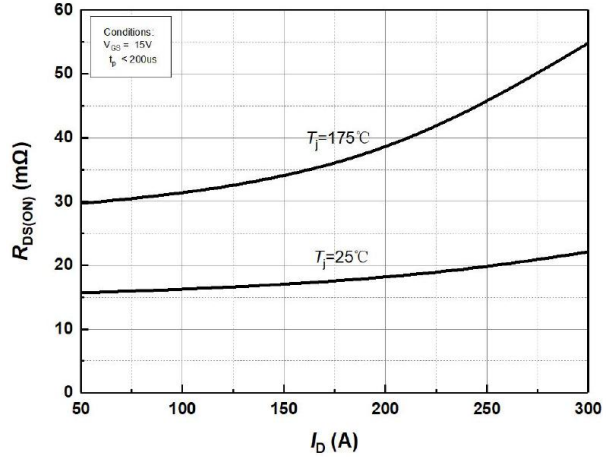


Figure 4. On-Resistance vs. Drain current for Various Temperature

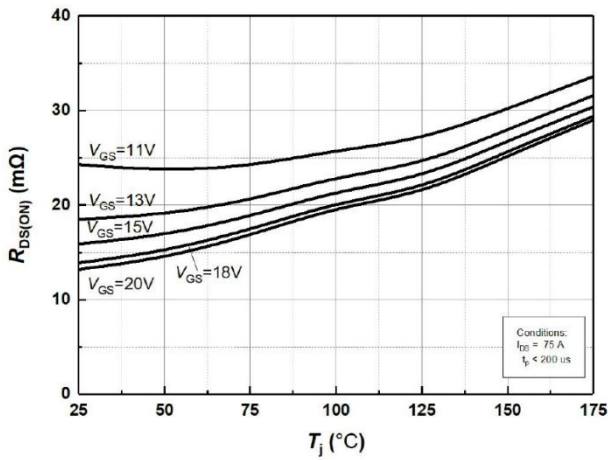


Figure 5. On-Resistance vs. Temperature for Various Gate Voltage

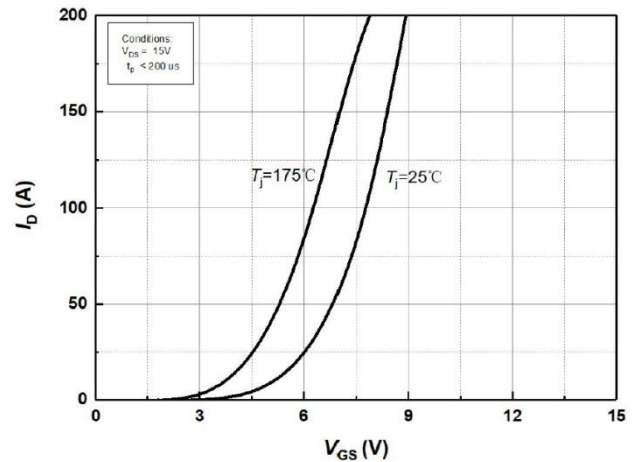


Figure 6. Transfer Characteristics for Various Junction Temperatures

## Typical Characteristics

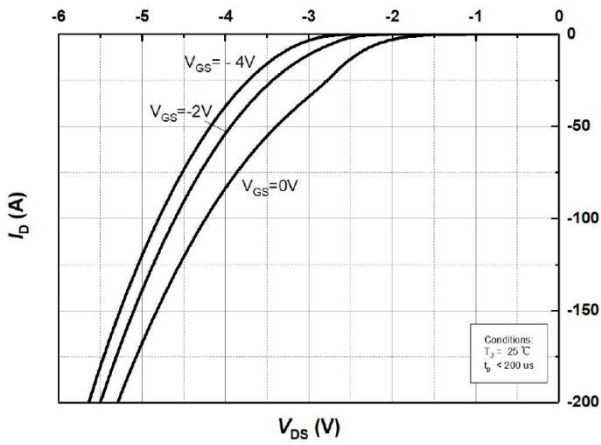


Figure 7. Body Diode Characteristics at Tj=25°C

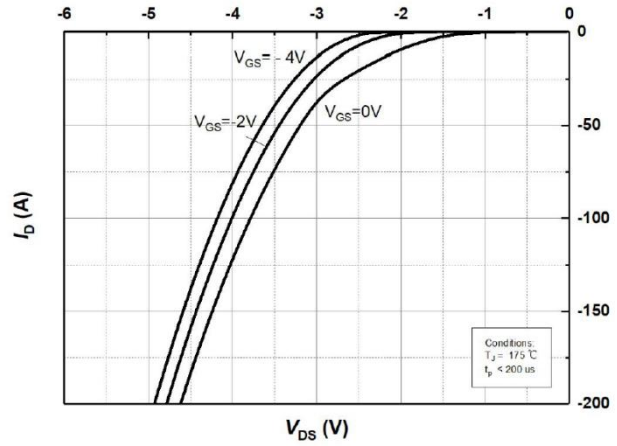


Figure 8. Body Diode Characteristics at Tj=175°C

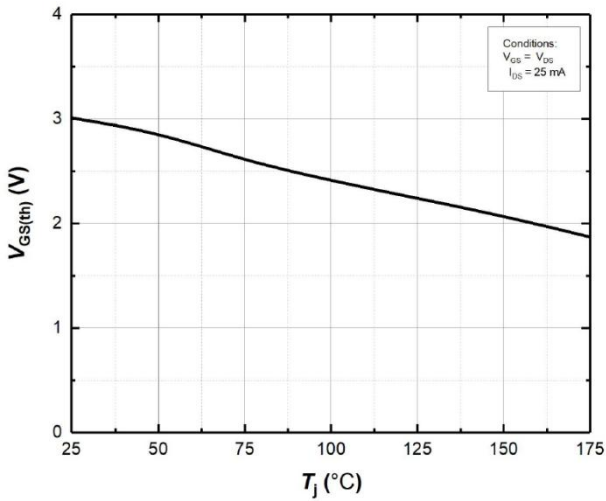


Figure 9. Threshold Voltage vs. Temperature

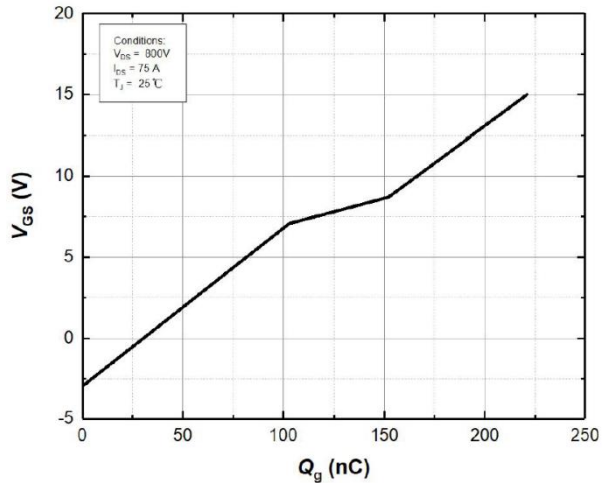


Figure 10. Gate Charge Characteristics

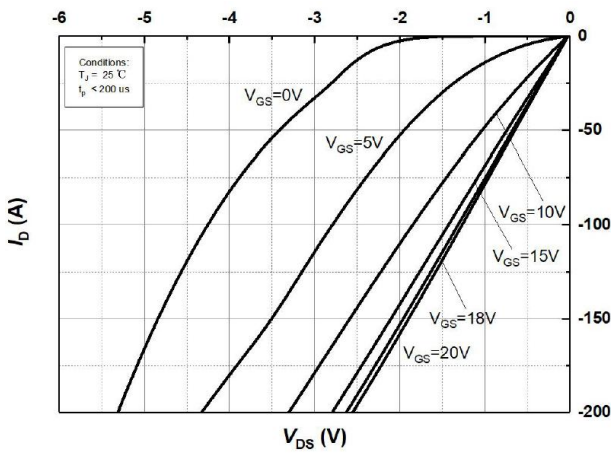


Figure 11. 3rd Quadrant Characteristic at Tj=25°C

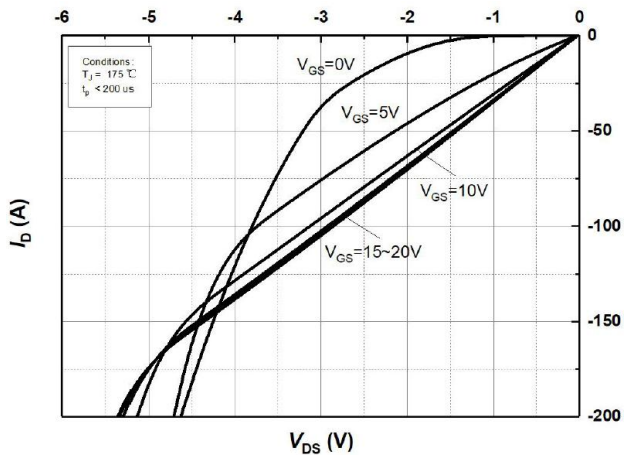


Figure 12. 3rd Quadrant Characteristic at Tj=175°C



### Typical Characteristics

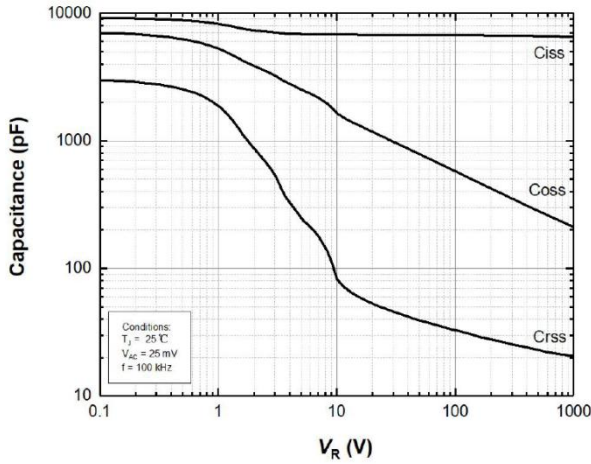


Figure 13. Capacitances vs. Drain-Source Voltage (0 – 1000V)

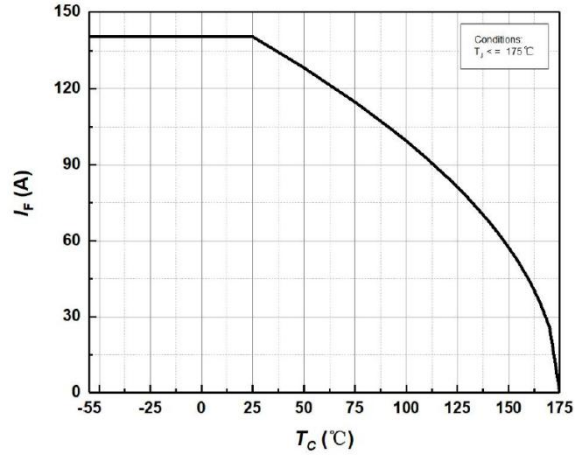


Figure 14. Continuous Drain Current Derating vs Case Temperature

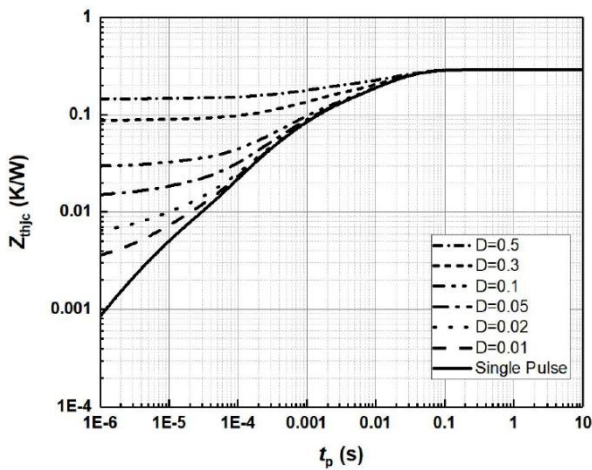


Figure 15. Transient Thermal Impedance (Junction – Case)

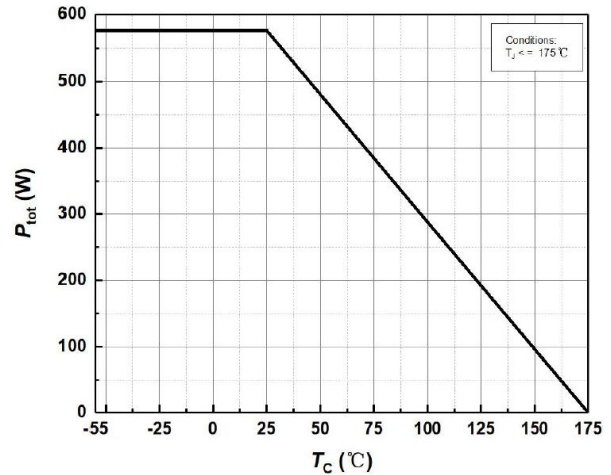


Figure 16. Maximum Power Dissipation Derating vs. Case Temperature

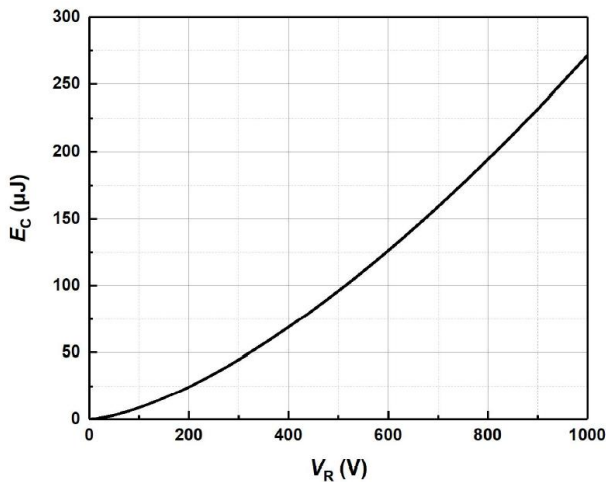


Figure 17. Output Capacitor Stored Energy

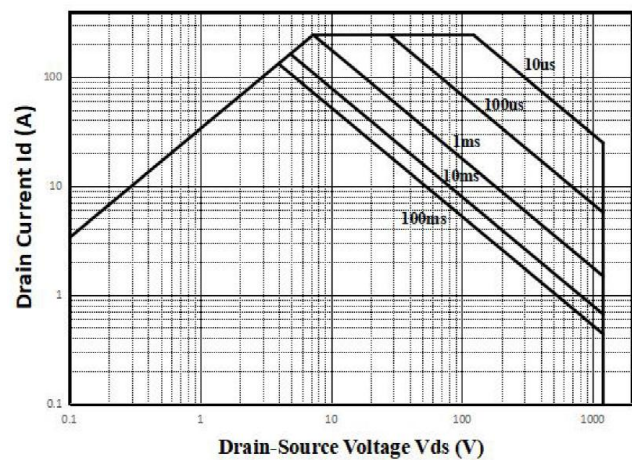
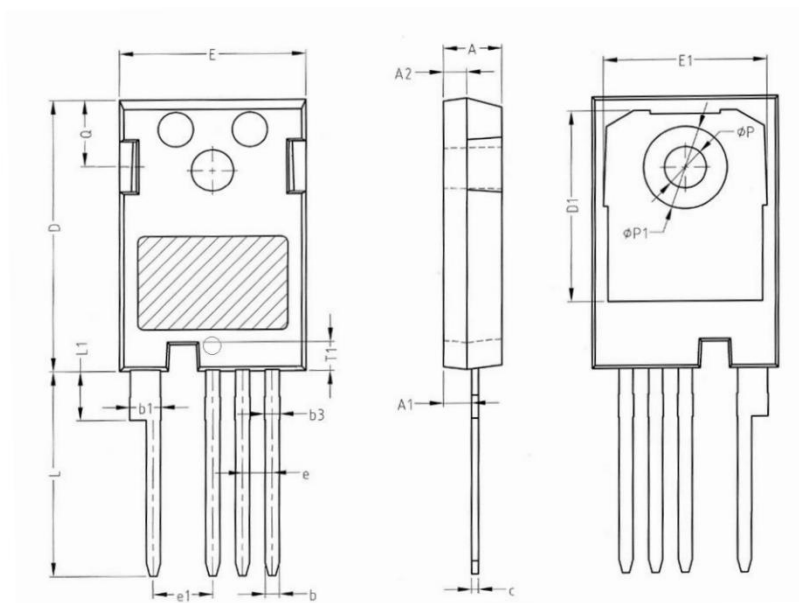


Figure 18. Safe Operating Area

### TO-247-4 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.800	5.210	0.189	0.205
A1	2.210	2.610	0.087	0.103
A2	1.800	2.200	0.071	0.087
b	1.060	1.360	0.042	0.054
b1	2.330	2.940	0.092	0.116
b3	1.070	1.600	0.042	0.063
c	0.510	0.750	0.020	0.030
D	23.300	23.600	0.917	0.929
D1	16.250	17.650	0.640	0.695
E	15.740	16.140	0.620	0.635
E1	13.100	14.320	0.516	0.564
T1	2.350	2.650	0.093	0.104
e	2.540 BSC		0.100 BSC	
e1	5.080 BSC		0.200 BSC	
Q	5.490	6.090	0.216	0.240
L	17.270	17.870	0.680	0.704
L1	3.970	4.390	0.156	0.173
ΦP	3.400	3.800	0.134	0.150
ΦP1	7.190 REF		0.283 REF	